



Sustaining in Lean Practices – The Avoidance of Pitfalls in Lean Journey

by Ir. Dr. Lee Choo Yong and Ir. Dr. Mui Kai Yin

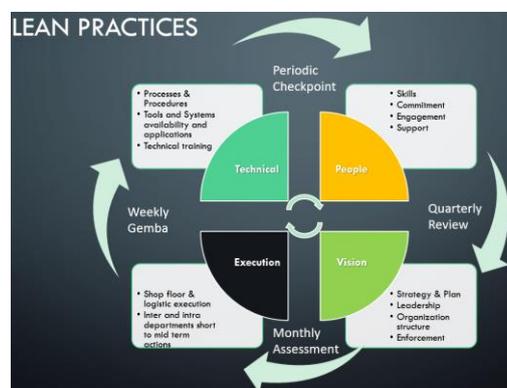
Ir. Dr. Lee Choo Yong is currently the Deputy Chairman in Electronic Engineering Technical Division (eETD).



Ir. Dr. Mui Kai Yin is currently the Honorary Secretary cum Treasurer in Electronic Engineering Technical Division (eETD).

Dr. Thong Sze Yee, Business Excellence Director of Flex, Penang delivered evening technical talk on “Sustaining in Lean Practices – The Avoidance of Pitfalls in Lean Journey” at IEM Penang Branch Secretariat on 26th September 2018. Total 16 IEM members attended this talk.

The talk commenced with introduction of speaker Dr. Thong by moderator Ir. Dr. Mui Kai Yin, Honorary Secretary cum Treasurer of IEM Electronics Engineering Technical Division (eETD). This talk provides audience a broader view of sustainable lean practices in various aspects, not only limited to manufacturing. Dr. Thong firstly introduced background of lean principles, and shared 3 steps of transformation to practices (I.S.E). It could be Introduction, Sustain, Excel or the other way round Introduction, Struggle, Exit depending on approaches of implementation.



Elements of lean practices

Dr. Thong then elaborated various approaches to cultivate lean practices not only at work but also in the whole community such as:

- Create a culture
- Integrated and actionable vision and principles
- Walk the behaviour, elevate the passion
- Practice lean around you
- Give the right amount tension (productive pushing)

Dr. Thong reiterated that lean journey is a comprehensive cycle, lean thinking is important to sustain lean practices. Participants have exchanged views intensively with Dr. Thong during the Q&A session, lean practices is a culture and it will take time to build up. The talk adjourned at 8:00pm after interactive Q&A, Ir. Dr. Mui presented certificate of appreciation to Dr. Thong for her sharing.



Left – Participants listening to Dr. Thong attentively. Right – Presentation of certificate by moderator Ir. Dr. Mui Kai Yin